

Vishay Siliconix

Dual N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0235 at V _{GS} = 10 V	8.5	6.7			
30	$0.028 \text{ at V}_{GS} = 4.5 \text{ V}$	7.8	0.7			

FEATURES

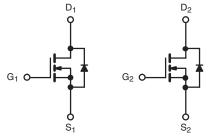
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- · PC System Power
- Low Current DC/DC



N-Channel MOSFET

N-Channel MOSFET

	SO-8	_
S ₁ 1		8 D ₁
G ₁ 2		7 D ₁
S ₂ 3		6 D ₂
G ₂ 4		5 D ₂
	Top View	J

Ordering Information: Si4214DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

ABSOLUTE MAXIMUM RATINGS TA	= 25 °C, unless other	wise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V_{DS}	30	V		
Gate-Source Voltage	V_{GS}	± 20			
	T _C = 25 °C		8.5		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	I _D	6.8		
Continuous Brain Current (1) = 100 °C)	T _A = 25 °C	ď	6.8 ^{b, c}		
	T _A = 70 °C		5.4 ^{b, c}		
Pulsed Drain Current		I _{DM}	30	Α	
Source-Drain Current Diode Current	T _C = 25 °C	I _S	2.8	1	
	T _A = 25 °C	'S	1.8 ^{b, c}		
Pulsed Source-Drain Current		I _{SM}	30	1	
Single Pulse Avalanche Current		I _{AS}	10]	
Single Pulse Avalanche Energy L = 0.1 mH		E _{AS}	5	mJ	
	T _C = 25 °C		3.1		
Maximum Pawar Dissination	T _C = 70 °C	P_D	2.0	w	
Maximum Power Dissipation	T _A = 25 °C	гD	2.0 ^{b, c}	VV	
	T _A = 70 °C		1.25 ^{b, c}]	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Тур.	Max.	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	52	62.5	°C/W		
Maximum Junction-to-Foot (Drain) Steady-State		$R_{th,lF}$	30	40	0,11		

Notes:

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 110 $^{\circ}\text{C/W}.$

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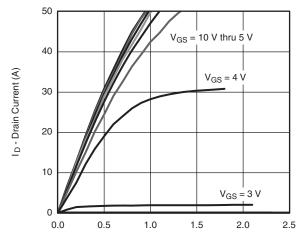
SPECIFICATIONS $T_J = 25 ^{\circ}\text{C}$, Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	,	<u> </u>		, ,,			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		3.5		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.2			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			100	nA	
	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			1	μА	
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V, TJ = 55 °C			10		
On -State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	20			Α	
		V _{GS} = 10 V, I _D = 7 A		0.0195	0.0235	Ω	
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 5 A		0.023	0.028		
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 7 A		35		S	
Dynamic ^a		<u> </u>					
Input Capacitance	C _{iss}			785		pF	
Output Capacitance	C _{oss}	N-Channel		125			
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ MHz}$		53			
·	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 8 A		15	23	nC	
Total Gate Charge		30 30 2		6.7	10.5		
Gate-Source Charge	Q_{gs}	N-Channel $V_{DS} = 15 \text{ V, } V_{GS} = 4.5 \text{ V, } I_{D} = 8 \text{ A}$		2.8			
Gate-Drain Charge	Q_{gd}	VDS = 13 V, VGS = 4.3 V, 1D = 0 A		2.0			
Gate Resistance	R_{g}	f = 1 MHz	0.4	2.1	4.2		
Turn-On Delay Time	t _{d(on)}			13	25		
Rise Time	t _r	N-Channel V_{DD} = 15 V, R_L = 3 Ω		11	22		
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_{q} = 1 \Omega$		18	35		
Fall Time	t _f	B = 0.9 GEN		9	18		
Turn-On Delay Time	t _{d(on)}			7	14	ns	
Rise Time	t _r	N-Channel $V_{DD} = 15 \text{ V, R}_{L} = 3 \Omega$		9	18		
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_{q} = 1 \Omega$		16	30		
Fall Time	t _f	D = 07, VGEN 1, 1.1g		8	16		
Drain-Source Body Diode Characterist	cs			•			
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.8	۸	
Pulse Diode Forward Current ^a	I _{SM}				30	A	
Body Diode Voltage	V_{SD}	I _S = 1.8 A		0.77	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			35	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	N-Channel		40	70	nC	
Reverse Recovery Fall Time	t _a	$I_F = 2.2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		19		0	
Reverse Recovery Rise Time				16		nS	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



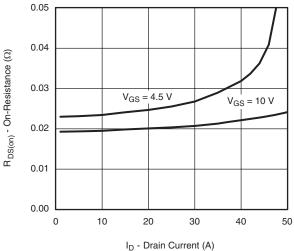
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

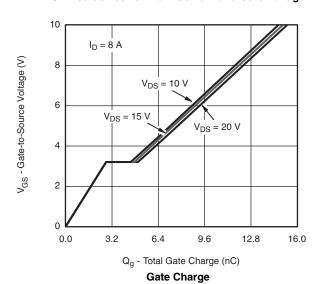


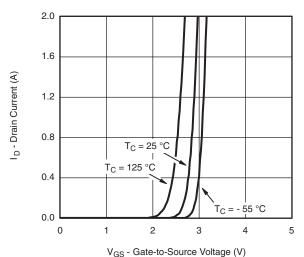
V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics



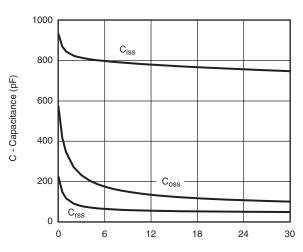
On-Resistance vs. Drain Current and Gate Voltage





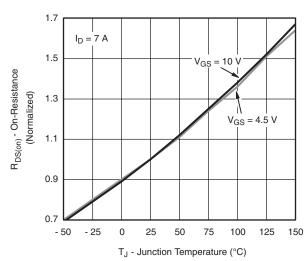
VGS Gate to Godfee Voltage (V)

Transfer Characteristics



V_{DS} - Drain-to-Source Voltage (V)

Capacitance



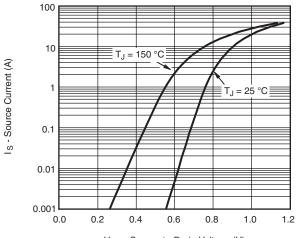
On-Resistance vs. Junction Temperature

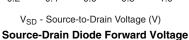
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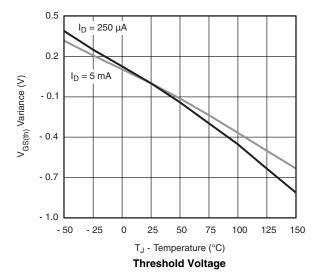
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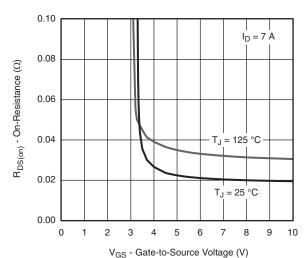
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

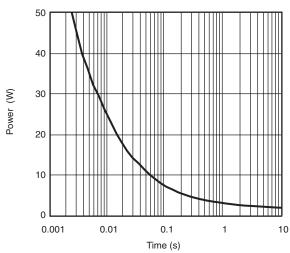




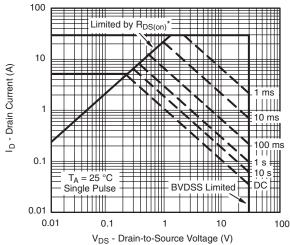




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



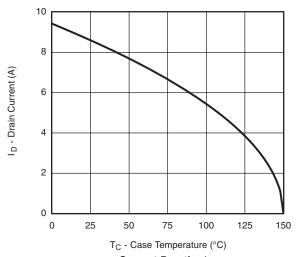
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

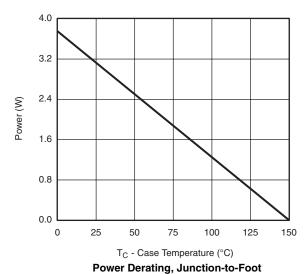


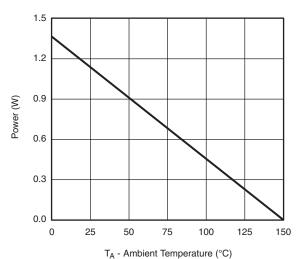
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Current Derating*





Power Derating, Junction-to-Ambient

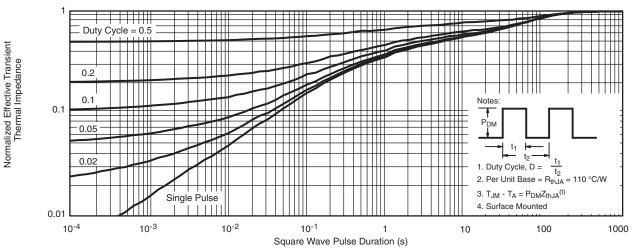
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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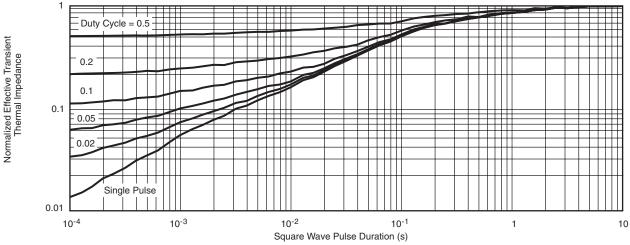
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppq?64726.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIMETERS INCHES			HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I. 11-Sep-06					

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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Revision: 13-Jun-16 1 Document Number: 91000